


<b>Search Notes</b> 	<b>Application/Control No.</b> 10826003	<b>Applicant(s)/Patent Under Reexamination</b> SHEI ET AL.
	<b>Examiner</b> Leonardo Andújar	<b>Art Unit</b> 2826

SEARCHED			
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257	99, 678, 778	9/14/2008	LA

SEARCH NOTES		
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INTERFERENCE SEARCH			
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